

# GREENWALD & BASCH LLP

G8 3739 #8/105

Practice concentrated in Intellectual Property Law

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November 6, 2002

Subject:

Information Disclosure Statement

NOV 1 3 2002 TECHNOLOGY CENTER R3700

Application:

Group Art Unit: 3739

U.S.S.N.:

10/077,978

Filing Date:

February 19, 2002

Attorney Docket:

**BTI-16** 

Enclosures:-

Information Disclosure Statement Patent Documents

Information Disclosure Statement Non-Patent Literature

Copies of References

Transmittal Form
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TECHNOLOGY CENTER R3700

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## **TRANSMITTAL FORM**

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Application Number	10/077,978	
Filing Date	February 19, 2002	
First Named Inventor	Patrick R. Connelly	
Group Art Unit	3739	
Examiner Name	•	
Attorney Docket Number	BTI-16	_

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		ENCL	OSURES	(check	k all that apply)		
Fee Transmittal For	m		nent Papers	·	After Allowance Communication to Group		
Fee Attache	d	Drawing	(s)		Appeal Communication to Board of Appeals and Interferences		
Amendment / Reply	у	Licensin	g-related Papers		Appeal Communication to Group (Appeal Notice, Brief, Reply Brief)		
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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Application of

In application of:

Application No.:
Confirmation No:

10/077,978

5038

Filed: For: February 19, 2002

Examiner:

Group No.: 3739

An Electromagnetic Interference Immune Tissue Invasive System

Assistant Commissioner for Patents Washington, D.C. 20231

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# IDENTIFICATION OF TIME OF FILING THE ACCOMPANYING INFORMATION DISCLOSURE STATEMENT

1) The information disclosure statement submitted herewith is being filed within three months of the filing date of the application or date of entry into the national stage of an international application or before the mailing date of a first Office action on the merits, whichever event occurs last. 37 C.F.R. section 1.97(b).

or

2) The Information Disclosure Statement submitted herewith contains information that was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Information Disclosure Statement. 37 C.F.R. section 1.97 (e) (1)

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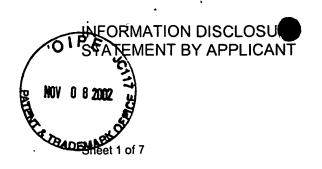
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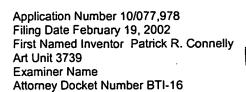
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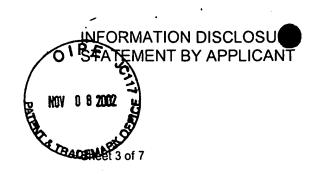


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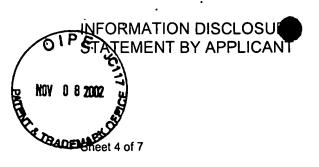


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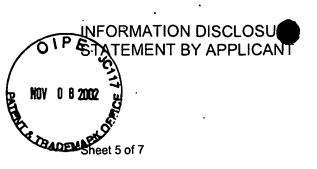
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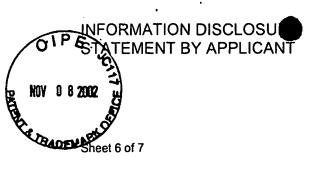
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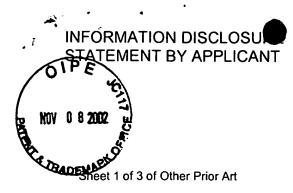
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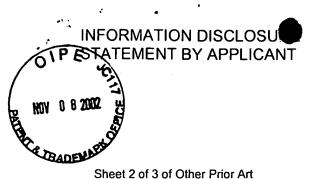
Application Number 10/077,978

Filing Date February 19, 2002

First Named Inventor Patrick R. Connelly FCHNOLOGY CENTER R3700

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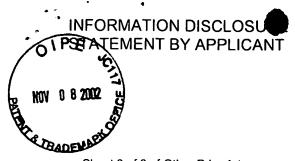
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